

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DRPARTMENT OF COMMERCE United States Patent and Trademark Office Address COMMISSIONICK, FOR PATENTS POR Part 150 Accorded, Veginia 22113-1450

BIBDATASHEET

Bib Data Sheet

CONFIRMATION NO. 4114

,	······································	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	·····			
SERIAL NUMBE 09/978,258	FILING DATE 10/15/2001 RULE	CLASS 250	GROUP ART I	TINL	ATTORNEY DOCKET NO. S004-4416		
APPLICANTS					··		
Akira Yonezawa, (Chiba-shi, JAPAN;						
** CONTINUING D	ATA ***********************************						
ler noxi							
** FOREIGN APPL JAPAN 2000-3213		**					
en nome							
IF REQUIRED, FO ** 11/14/2001	REIGN FILING LICENSE G	RANTED		2000011002000110000	**********	(22.2220.00.00.00.00.00.00.00.00.00.00.00	
Foreign Priority claimed 35 USC 119 (a-d) condit	tions yes no Met aff	STATE OR	SHEETS	TOTAL		INDEPENDENT	
net /erifled and Acknowledged Examiner's Signature Initials		COUNTRY nitials JAPAN	DRAWING 5	CLAIMS 8		CLAIMS 2	
ADDRESS ADAMS & WILKS 31st Floor 50 Broadway New York , NY 10004						: :	
TITLE Electromagnetic fie lens	eld superimposed lens and	electron beam device u	sing this electror	nagnet	ic field	superimposed	
			☐ All F	All Fees			
		\$\$ <u></u>	1.16 Fees (Filing)				
FILING FEE FI	EES: Authority has been giv	☐ _{1.17}	1.17 Fees (Processing Ext. of				
RECEIVED N	o for following:		1.18 Fees (Issue)				
1154			Other				
		∯⊡ ~	in				